

**Search Notes**

Application/Control No.

10/700,614

Examiner

Sing P. Chan

Applicant(s)/Patent under  
Reexamination

KINNE ET AL.

Art Unit

1734

**SEARCHED**

Class	Subclass	Date	Examiner
156	71, 184, 191, 459, 523, 530	10/30/2006	SPC
156	574 577 579	10/30/2006	SPC
156	580 583.8	10/30/2006	SPC
15	235.3	10/30/2006	SPC
15	235.4	10/30/2006	SPC
15	235.7	10/30/2006	SPC
425	458	10/30/2006	SPC
16	374 375 385	10/30/2006	SPC
16	355	10/30/2006	SPC
222	43, 80, 83	10/30/2006	SPC
222	83.5, 89	10/30/2006	SPC
222	90, 245	10/30/2006	SPC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
156	71, 184	10/30/2006	SPC
156	191, 459	10/30/2006	SPC
156	523, 530	10/30/2006	SPC
156/574, 577, 579, 580, 583.8; 15/235.3, 235.4, 235.7		10/30/2006	SPC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text and image search on EAST	10/30/2006	SPC
Inventors search on EAST and PALM on Daniel Kinne and Mark Steinhart	10/30/2006	SPC
PGPUB text search on EAST	10/30/2006	SPC

**Search Notes (continued)**

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222/43, 80, 83, 83.5, 89, 90, 245		10/30/2006	SPC

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(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR